

Search Notes

Application/Control No.

10/033,559

Examiner

Jung Park

Applicant(s)/Patent under
Reexamination

FURUNO, TAKAYUKI

Art Unit

2661

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

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Interference Search History Printout		2/21/2006	JP

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted with Chau Nguyen 370/389, 392, 401-403; 709/238 (text search only - see history printout)	2/16/2006	JP
EAST (USPAT, US-PGPUB) - see history printout	2/16/2006	JP